UNISONIC TECHNOLOGIES CO., LTD

6N65-C **Preliminary** Power MOSFET

6A, 650V N-CHANNEL **POWER MOSFET**

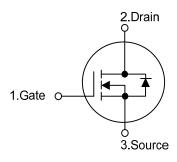
DESCRIPTION

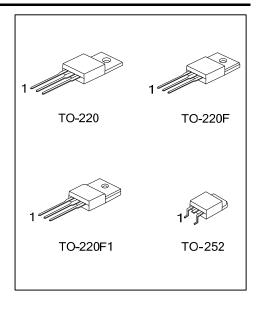
The UTC 6N65-C is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

FEATURES

- * $R_{DS(ON)}$ < 1.7 Ω @ V_{GS} =10V, I_{D} =3A
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

SYMBOL

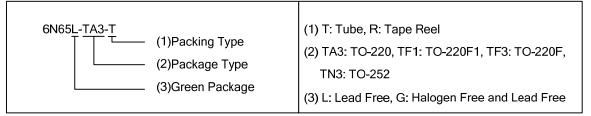




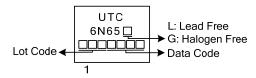
ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing	
Lead Free	Halogen Free	Fackage	1	2	3	Facking	
6N65L-TA3-T	6N65G-TA3-T	TO-220	G	D	S	Tube	
6N65L-TF1-T	6N65G-TF1-T	TO-220F1	G	D	S	Tube	
6N65L-TF3-T	6N65G-TF3-T	TO-220F	G	D	S	Tube	
6N65L-TN3-R	6N65G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING



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■ **ABSOLUTE MAXIMUM RATINGS** (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	650	٧
Gate-Source Voltage		V_{GSS}	±30	V
Avalanche Current (Note 2)		I _{AR}	6	Α
Continuous Drain Current		I _D	6	Α
Pulsed Drain Current (Note 2)		I _{DM}	24	Α
Avalanche Energy (Note 3)	Single Pulsed	E _{AS}	360	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3	ns
Power Dissipation	TO-220		120	W
	TO-220F/TO-220F1	P _D	40	W
	TO-252		125	W
Junction Temperature		T_J	+150	ů
Operating Temperature		T _{OPR}	-55 ~ + 150	°C
Storage Temperature		T _{STG}	-55 ~ + 150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating : Pulse width limited by $T_{\sf J}$
- 3. L = 20mH, I_{AS} = 6A, V_{DD} = 90V, R_{G} = 25 Ω , Starting T_{J} = 25°C
- 4. $I_{SD} \le 6A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL RESISTANCES CHARACTERISTICS

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220/TO-220F TO-220F1	θ_{JA}	62.5	°C/W
	TO-252		110	°C/W
Junction to Case	TO-220		1.04	°C/W
	TO-220F/TO-220F1	θ_{JC}	3.2	°C/W
	TO-252		40	°C/W

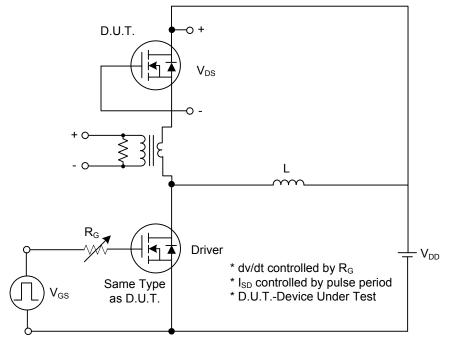
■ **ELECTRICAL CHARACTERISTICS** (T_J =25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	V_{GS} =0V, I_D =250 μ A	650			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =650V, V _{GS} =0V			10	μΑ
			V _{DS} =520V, V _{GS} =0V, T _J =125°C			100	μΑ
Gate- Source Leakage Current	Forward	- Gee	V_{GS} =30V, V_{DS} =0V			100	nA
	Reverse		V_{GS} =-30V, V_{DS} =0V			-100	nA
Breakdown Voltage Temperature	Coefficient	$\triangle BV_{DSS}/\triangle T_J$	I _D =250μA, Referenced to 25°C		0.53		V/°C
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V_{GS} =10V, I_D =3A			1.7	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C_{ISS}			350		pF
Output Capacitance		Coss	V _{DS} =25V, V _{GS} =0V, f=1.0 MHz		85		pF
Reverse Transfer Capacitance		C_{RSS}			7		pF
SWITCHING CHARACTERISTICS	S						
Total Gate Charge		Q_G	V _{DS} =50V, I _D =1.3A, V _{GS} =10V,		100		nC
Gate-Source Charge		Q_GS	I _G =100μA (Note 1, 2)		7		nC
Gate-Drain Charge		Q_GD	IG-100μΑ (Note 1, 2)		7		nC
Turn-On Delay Time		$t_{D(ON)}$			55		ns
Turn-On Rise Time		t_{R}	V_{DD} =30V, I_{D} =0.5A, R_{G} =25 Ω		40		ns
Turn-Off Delay Time		t _{D(OFF)}	(Note 1, 2)		215		ns
Turn-Off Fall Time		t_{F}			45		ns
DRAIN-SOURCE DIODE CHARA	CTERISTIC	S AND MAXII	MUM RATINGS				
Drain-Source Diode Forward Voltage		V_{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 6 \text{ A}$			1.4	V
Maximum Continuous Drain-Source Diode		I _S				6	Α
Forward Current						U	^
Maximum Pulsed Drain-Source Diode		I _{SM}				24	Α
Forward Current							
Reverse Recovery Time		t_RR	$V_{GS} = 0 \text{ V}, I_{S} = 6 \text{ A},$		340		ns
Reverse Recovery Charge		Q_{RR}	dI _F /dt = 100 A/μs (Note 1)		3.5		μC

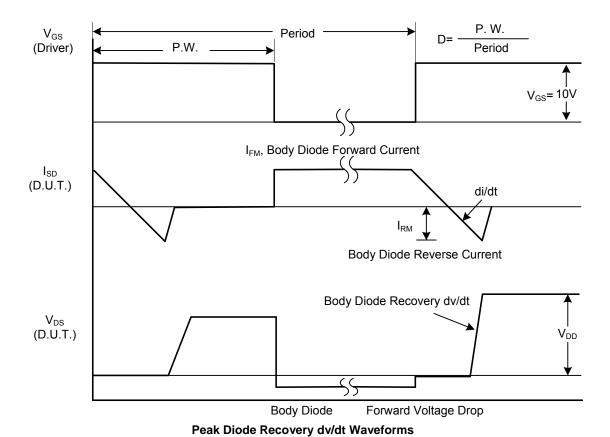
Notes: 1. Pulse Test: Pulse width \leq 300 μ s, Duty cycle \leq 2%

^{2.} Essentially independent of operating temperature

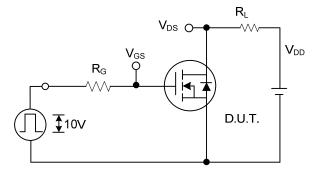
■ TEST CIRCUITS AND WAVEFORMS



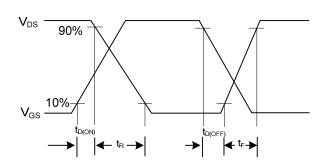
Peak Diode Recovery dv/dt Test Circuit



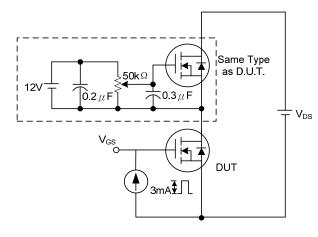
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



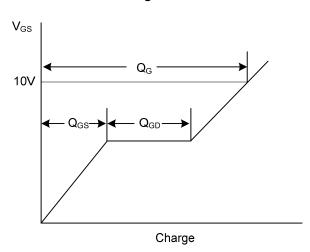
Switching Test Circuit



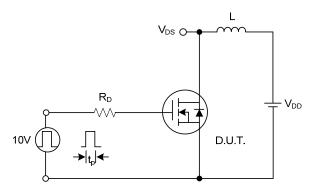
Switching Waveforms



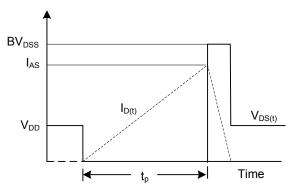
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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